

**Notice of References Cited**

Application/Control No.

10/050,286

Applicant(s)/Patent Under  
Reexamination  
DEAN ET AL.

Examiner

Vivek D Koppikar

Art Unit

1775

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	GB 2,243,578	11-1991	United Kingdom	Lowdon et al.	G09F003/02
	O	JP 06-122803	05-1994	Japan	Kozo	C08L033/10
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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